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Application/Control No.

Hoang-Vu A. Nguyen-Ba 2192

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,760,907	07-2004	Shaylor, Nicholas	717/158
*	В	US-5,664,159	09-1997	Richter et al.	703/23
*	С	US-6,071,317	06-2000	Nagel, Robert H.	717/128
*	D	US-6,077,312	06-2000	Bates et al.	717/129
*	Е	US-6,735,636	05-2004	Mokryn et al.	710/5
*	F	US-2003/0145251	07-2003	Cantrill, Bryan	714/35
*	G	US-6,769,117	07-2004	Moore, Richard John	717/130
*	Ι	US-7,000,225	02-2006	Sangavarapu et al.	717/129
*		US-6,928,639	08-2005	Juan et al.	717/127
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Jonathan B. Rosenberg, How Debuggers Work, 9/1996, Wiley Computer Publishing, Chapters 2, 5 and 6
	\	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.